

# **FDS2570**

# 150V N-Channel PowerTrench® MOSFET

### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers.

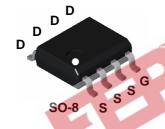
These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable  $R_{\text{DS(ON)}}$  specifications.

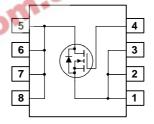
The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

### **Features**

• 4A, 150 V.  $R_{DS(ON)} = 80 \ m\Omega \ @ \ V_{GS} = 10 \ V$   $R_{DS(ON)} = 90 \ m\Omega \ @ \ V_{GS} = 6 \ V$ 

- · Low gate charge
- · Fast switching speed
- High performance trench technology for extremely low  $R_{\mbox{\scriptsize DS(ON)}}$
- · High power and current handling capability





### Absolute Maximum Ratings T<sub>A</sub>=25°C (

Symbol	Parameter		Ratings	Units
$V_{DSS}$	Drain-Source Voltage		150	V
V <sub>GSS</sub>	Gate-Source Voltage		±20	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	4	А
	- Pulsed		30	
P <sub>D</sub>	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1.0	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C

### **Thermal Characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	125	°C/W
R <sub>eJC</sub>	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

### **Package Marking and Ordering Information**

Device Marking	Device	Reel Size	Tape width	Quantity
FDS2570 FDS2570		13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-Sc	Durce Avalanche Ratings (Note	1)				
W <sub>DSS</sub>	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 75 \text{ V}, \qquad I_{D} = 4.4 \text{ A}$			375	mJ
I <sub>AR</sub>	Maximum Drain-Source Avalanche Current				4.4	Α
Off Char	racteristics	•				
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	150			V
$\Delta BV_{DSS} \over \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		150		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 120 V, V <sub>GS</sub> = 0 V			1	μА
I <sub>GSSF</sub>	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			100	NA
I <sub>GSSR</sub>	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V}$ $V_{DS} = 0 \text{ V}$			-100	NA
On Char	racteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2	2.6	4	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C	10	-7		mV/°C
R <sub>DS(on)</sub>	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, \qquad I_{D} = 4 \text{ A}$ $V_{GS} = 6 \text{ V}, \qquad I_{D} = 3.8 \text{ A}$ $V_{GS} = 10 \text{ V}, I_{D} = 4 \text{ A}, T_{J} = 125^{\circ}\text{C}$	3/11	60 63 120	80 90 158	mΩ
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 10 \text{ V}, \qquad V_{DS} = 10 \text{ V}$	30			Α
g <sub>FS</sub>	Forward Transconductance	$V_{DS} = 10 \text{ V}, \qquad I_{D} = 4 \text{ A}$		20		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	$V_{DS} = 75 \text{ V}, \qquad V_{GS} = 0 \text{ V},$		1907		PF
Coss	Output Capacitance	f = 1.0 MHz		117		PF
C <sub>rss</sub>	Reverse Transfer Capacitance			33		PF
Switchir	ng Characteristics (Note 2)					
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 75 \text{ V}, \qquad I_D = 1 \text{ A},$		12	19	Ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10 \text{ V}, \qquad R_{GEN} = 6 \Omega$		7	14	Ns
t <sub>d(off)</sub>	Turn-Off Delay Time			41	65	Ns
t <sub>f</sub>	Turn-Off Fall Time			21	34	Ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 75 \text{ V}, \qquad I_{D} = 4 \text{ A},$		39	62	NC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		7		NC
$Q_{gd}$	Gate-Drain Charge			9		NC
Drain-S	ource Diode Characteristics a	and Maximum Ratings				
Is	Maximum Continuous Drain-Source				2.1	Α
V <sub>SD</sub>	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V},  I_{S} = 2.1 \text{ A}  \text{(Note 2)}$		0.7	1.2	V

#### Notes:

R<sub>8JA</sub> is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of
the drain pins. R<sub>8JC</sub> is guaranteed by design while R<sub>8CA</sub> is determined by the user's board design.



a) 50°/W when mounted on a 1in² pad of 2 oz copper



b) 105°/W when mounted on a .04 in<sup>2</sup> pad of 2 oz copper



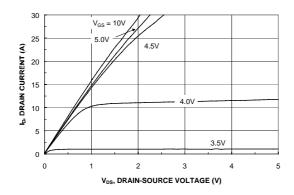
c) 125°/W when mounted on a minimum pad.



**2.** Pulse Test: Pulse Width <  $300\mu$ s, Duty Cycle < 2.0%

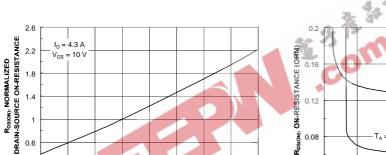


## **Typical Characteristics**



1.6 V<sub>GS</sub> = 4.0V V<sub>GS</sub> = 4.0V V<sub>GS</sub> = 4.0V V<sub>GS</sub> = 5.0V V<sub>GS</sub> = 4.0V V

Figure 1. On-Region Characteristics.



100

125

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

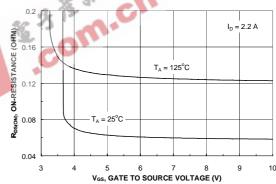


Figure 3. On-Resistance Variation with Temperature.

50

T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

0

0.2

-50

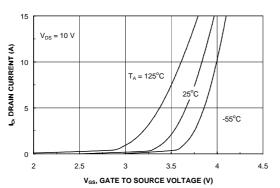


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

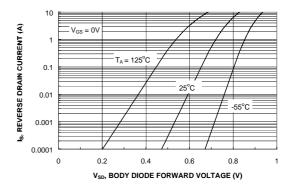
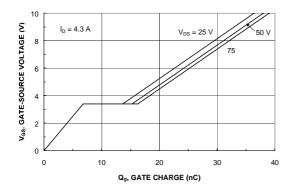


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## **Typical Characteristics**



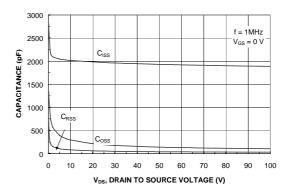


Figure 7. Gate Charge Characteristics.

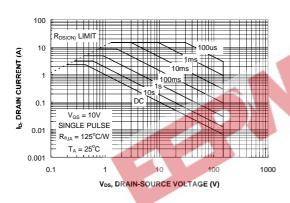


Figure 8. Capacitance Characteristics.

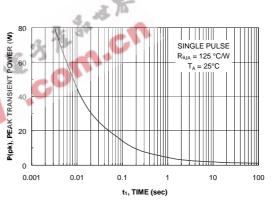


Figure 9. Maximum Safe Operating Area.



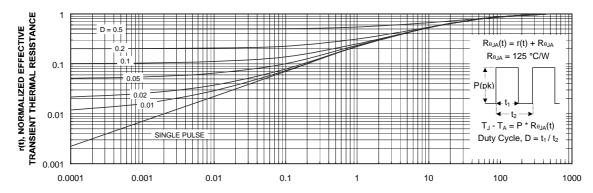


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

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